

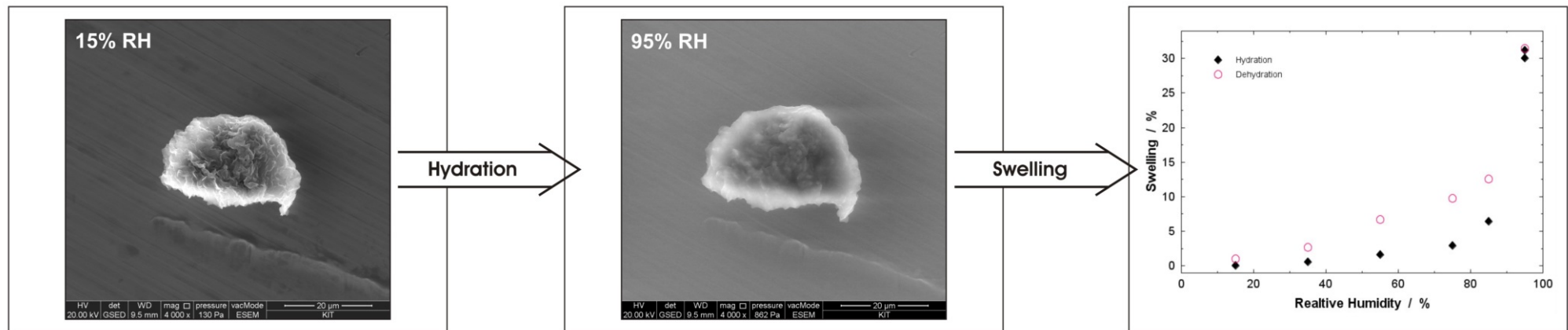
Environmental Scanning Electron Microscopy (ESEM)

Investigation of (wet) Clays

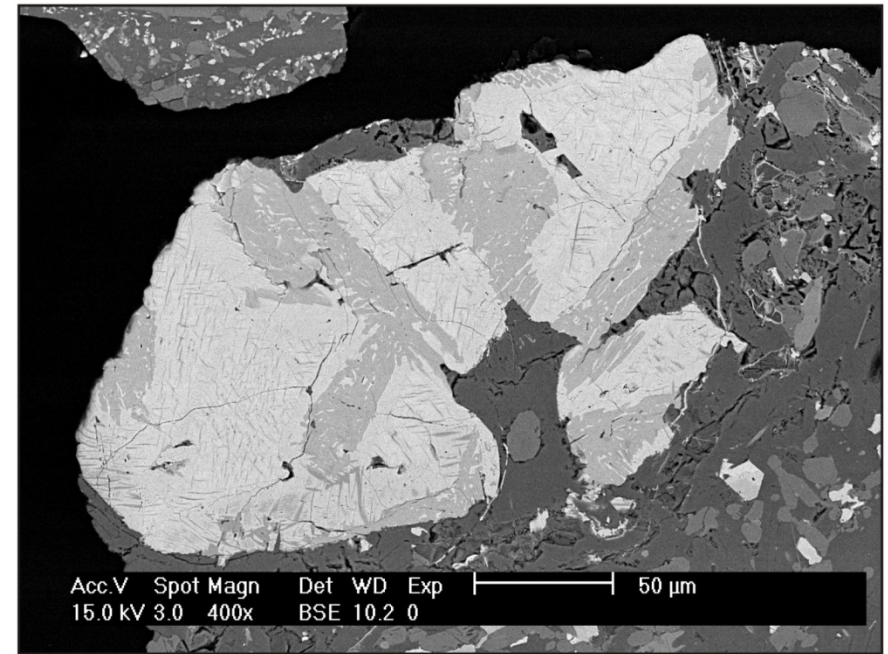
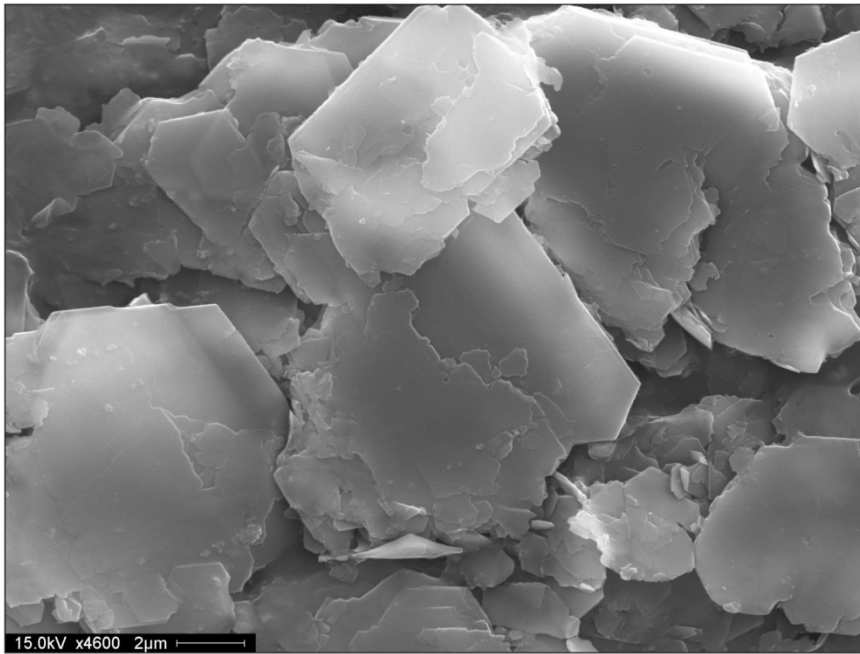
Frank Friedrich



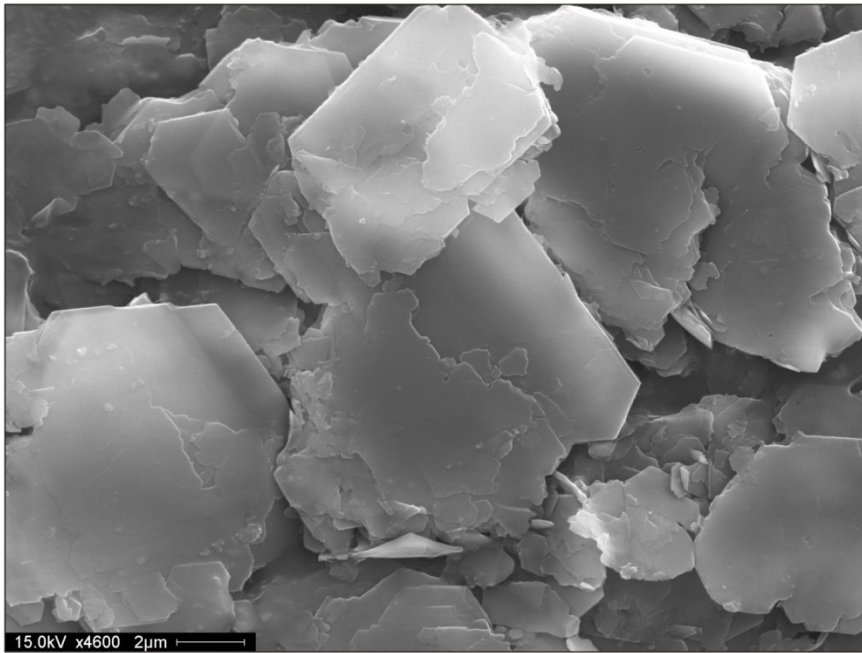
INSTITUTE FOR NUCLEAR WASTE DISPOSAL (INE)



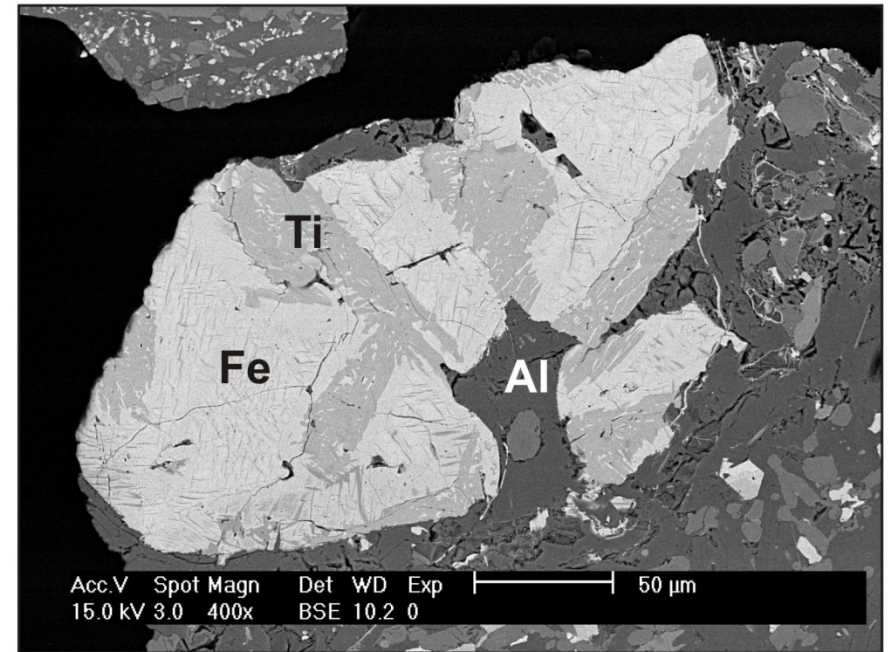
Characteristics of SEM



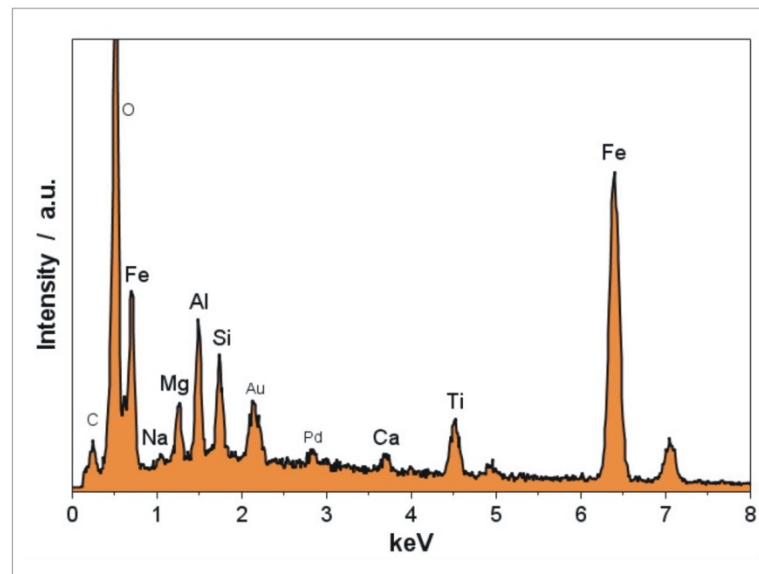
Characteristics of SEM



Imaging
(Secondary electrons, SE)



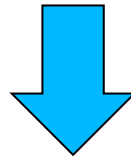
Imaging + Chemical information
(backscattered electrons, BSE)



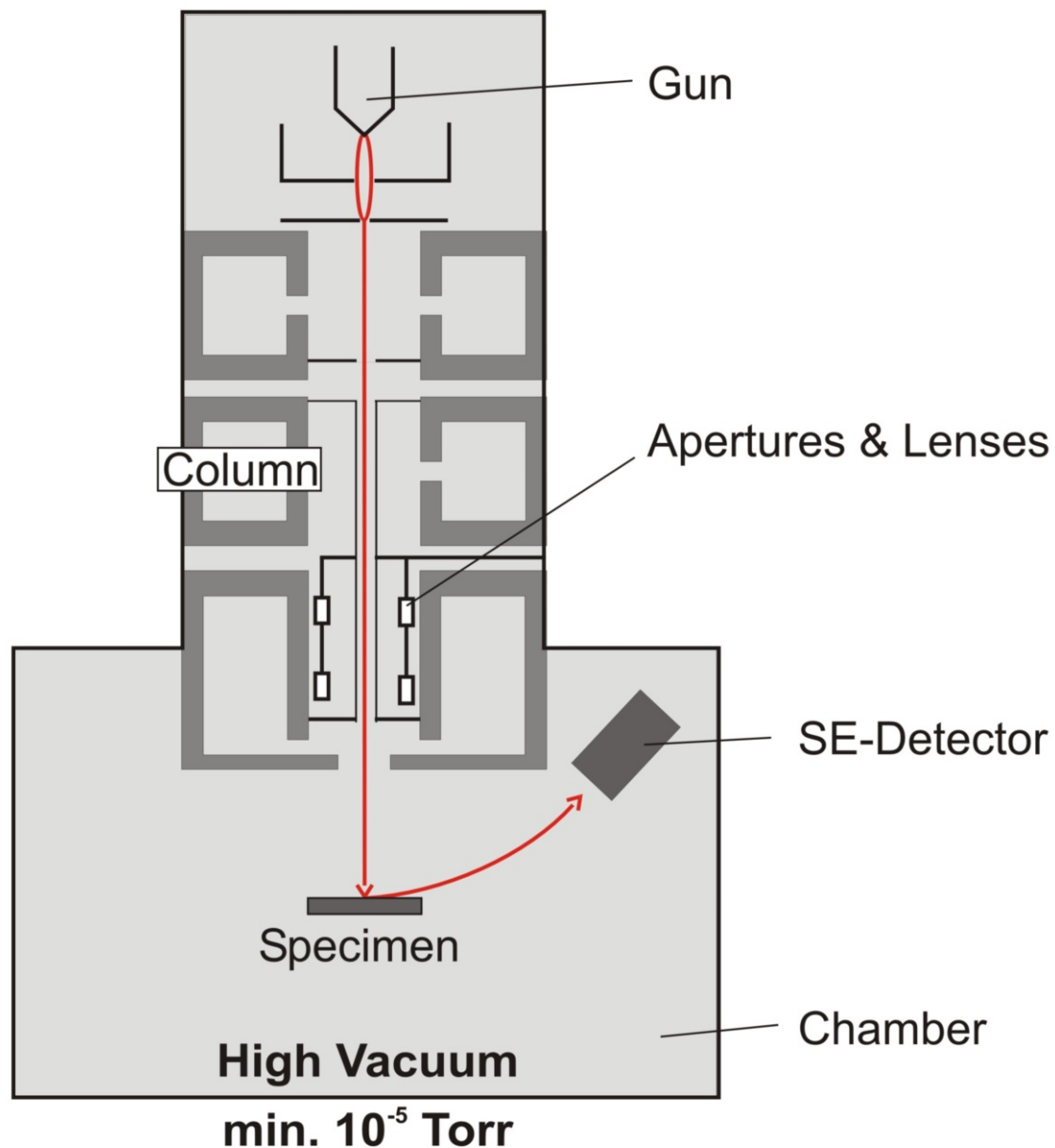
Chemical information
(X-rays)

Characteristics of SEM

- Imaging of topography / morphology of massive specimen
- **Three-dimensional look of images – high depth of field**
- **Simultaneous imaging and chemical information (X-rays, BSE)**
- Chemical composition (material contrast)
- Imaging of various kinds of materials, even "wet" and "sensitive" (biological) samples
- High resolution (1 nm)



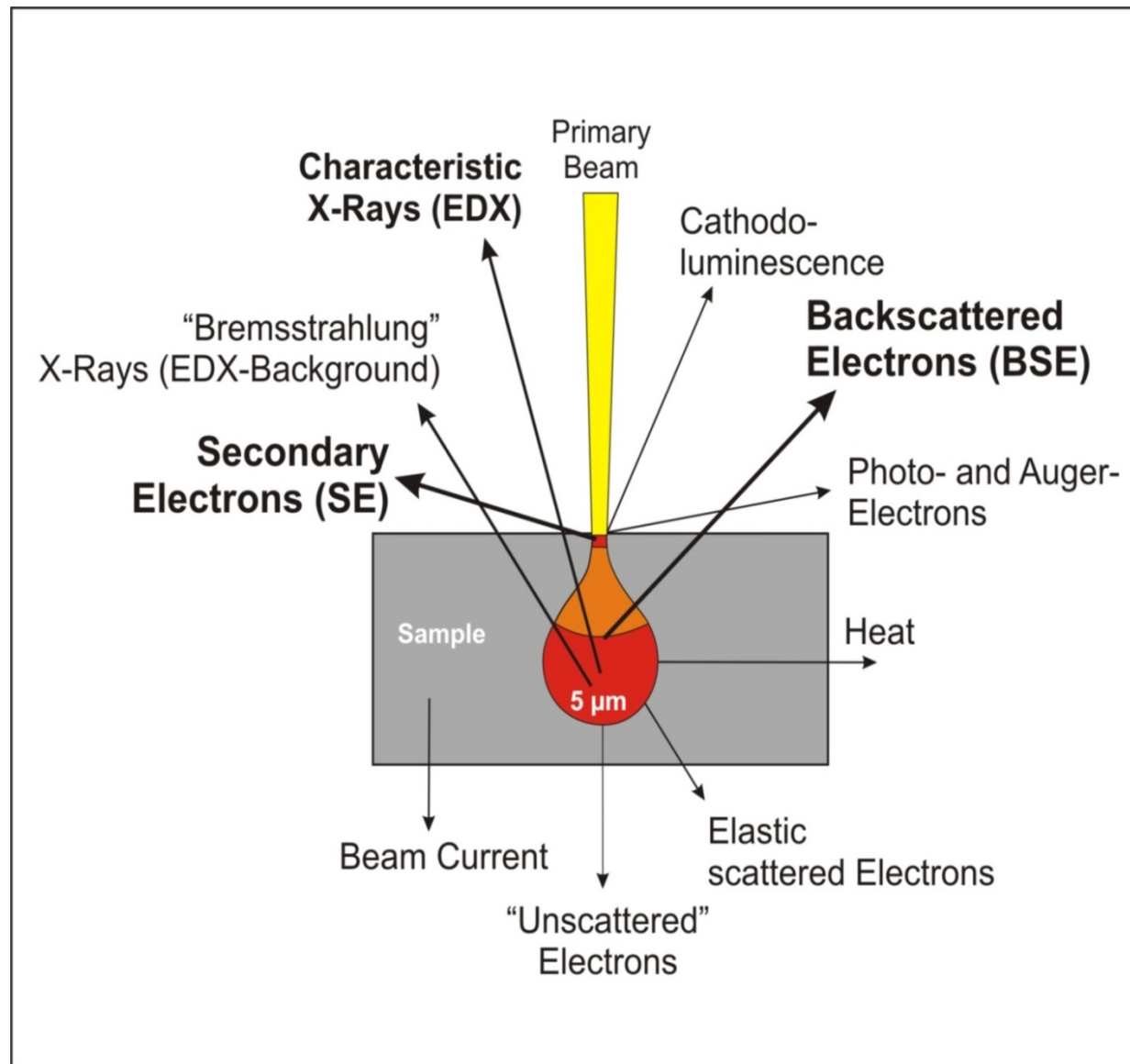
Result of the Interaction between
é-Beam and Sample Material



SEM-Principles

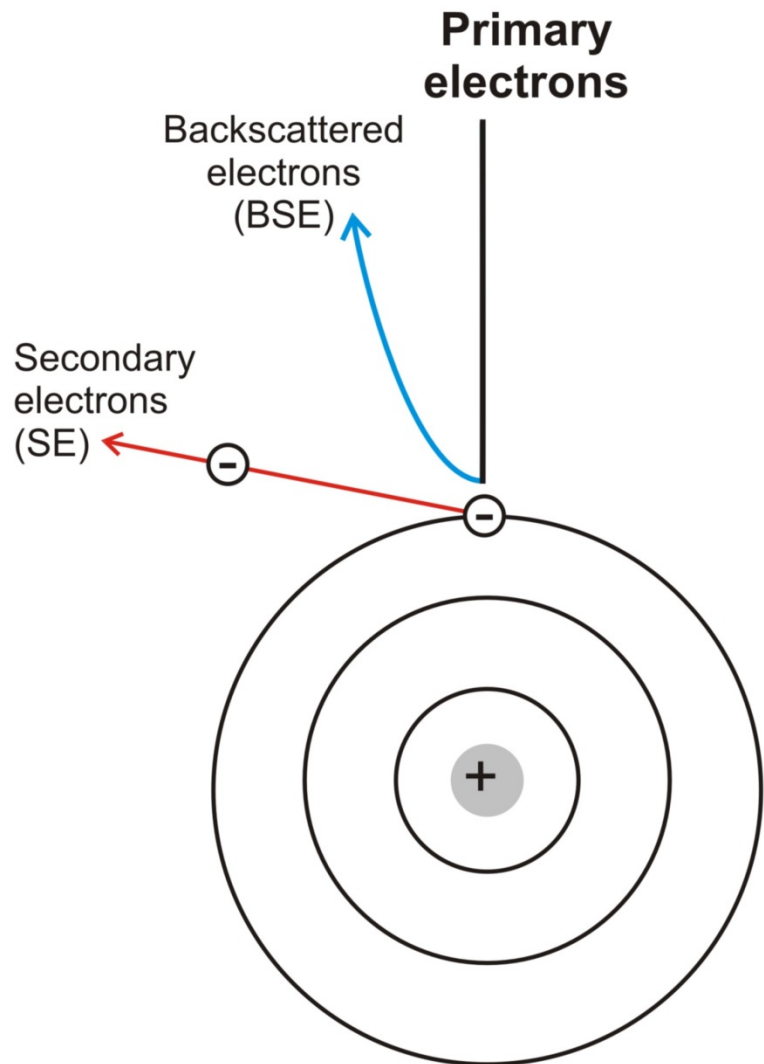
- Electron source produces e⁻-beam
(High vacuum: $< 10^{-5}$ Pa)
(Acceleration voltages: 1-30 kV)
- Beam is finely focused on the specimen by (condenser and objective) lenses
- Lenses: magnetic fields
- Focused spot is scanned across the specimen
- Interaction beam - sample
- Emitted and scattered electrons (and photons, X-rays) are collected by detectors
- *Sample preparation*
(complex) drying procedures, conductive coating (Au, Pt,...)

Characteristics of SEM

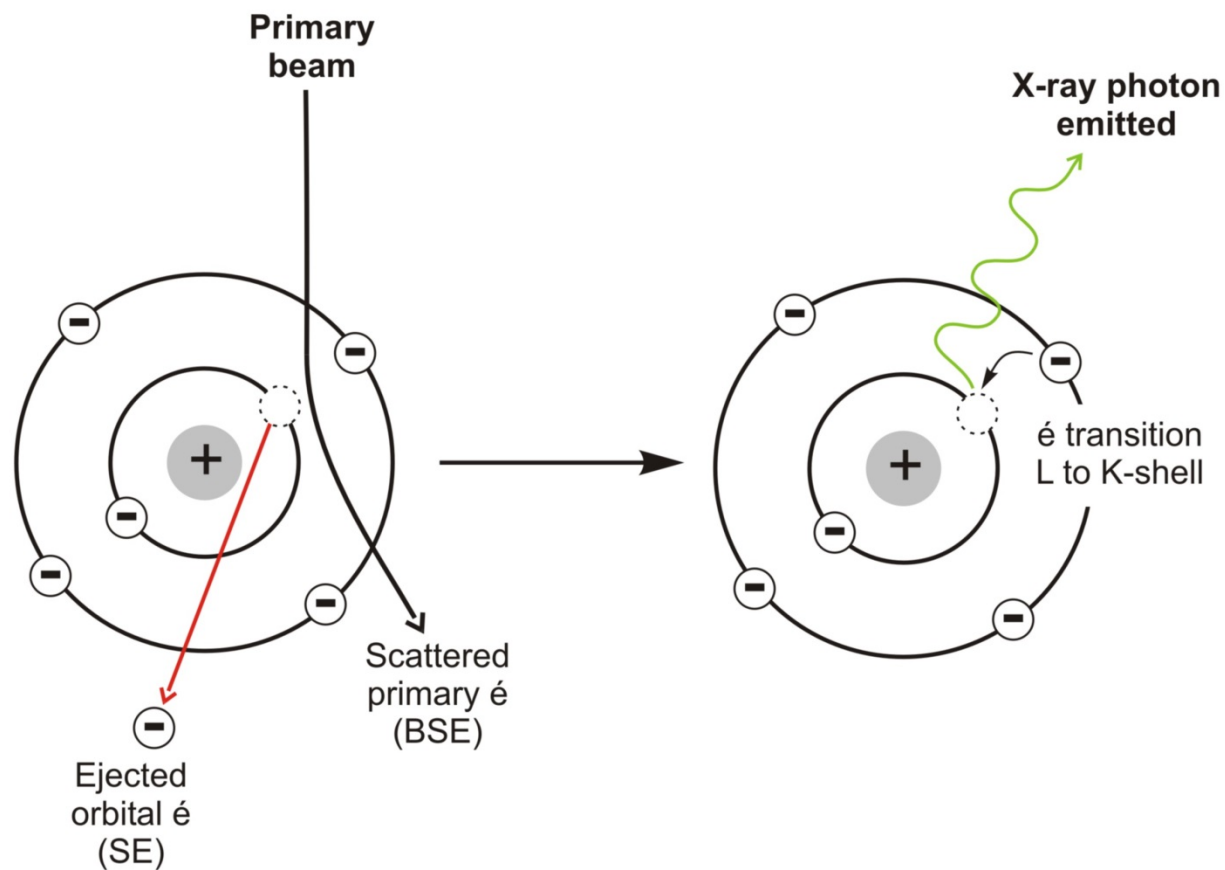


Electron Matter Interaction

1.) e^- ejected from outer shells

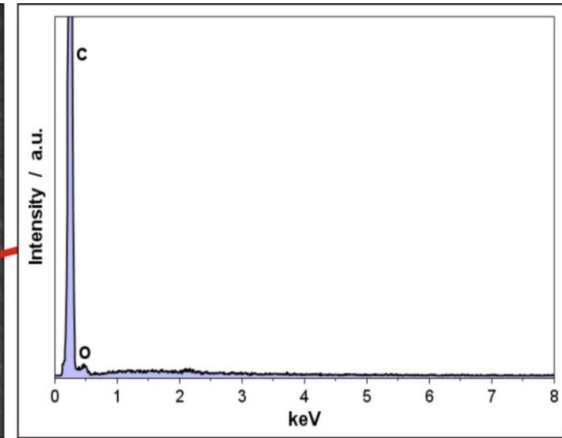
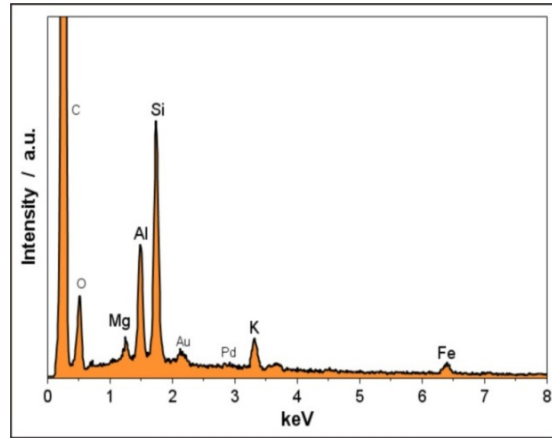


2.) e^- ejected from inner shells / X-ray / photoelectrons (Auger-electrons)

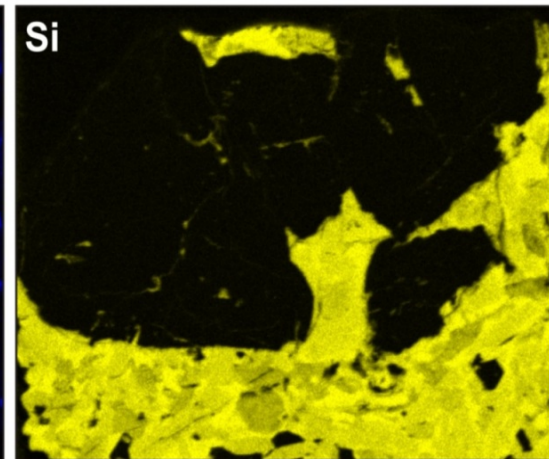
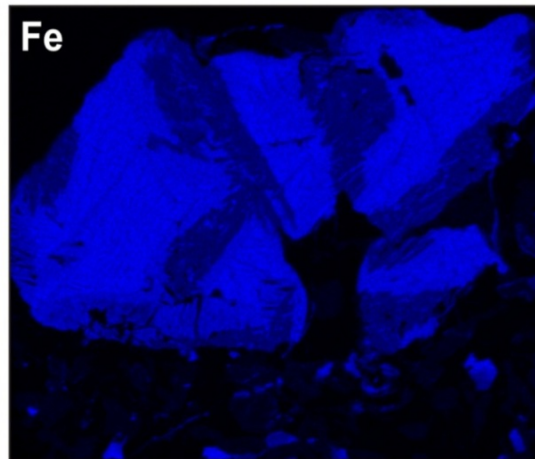
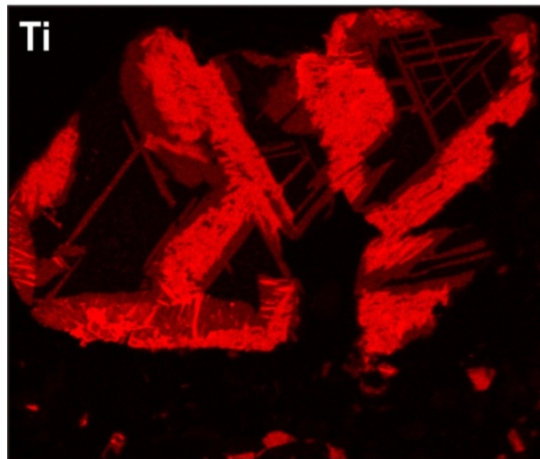
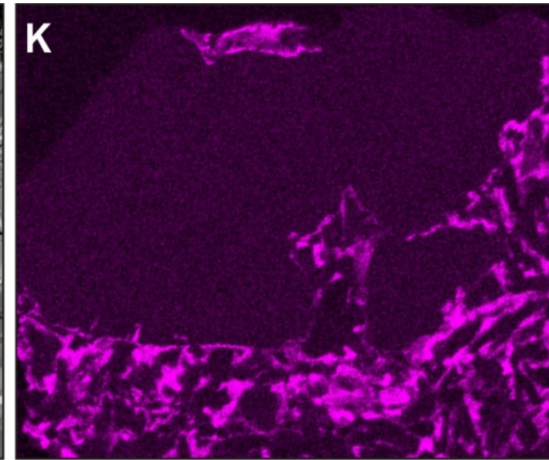
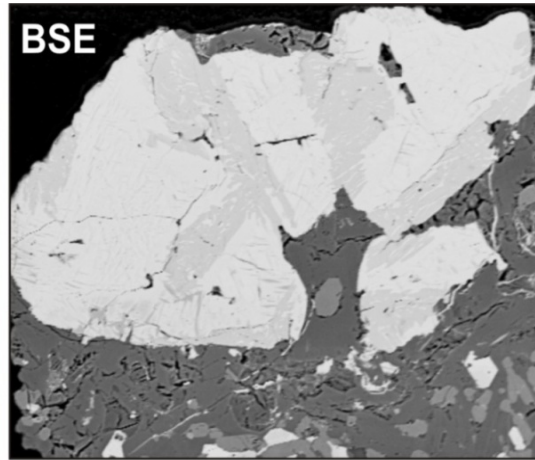
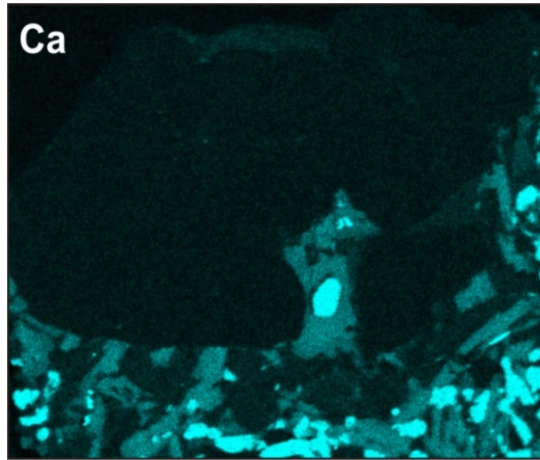


Electron Matter Interaction

Spectra

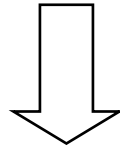


Elemental Mapping



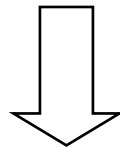
Limitations of High-Vac SEM

- Insulating specimens have to be covered with conductive material
this avoids electrical charge effects
- High vacuum ($< 10^{-5}$ Pa) destroys sensitive samples
e.g. hydrated or intercalated clay minerals
- Gas in the column interferes with the beam
destroys the sensitive high vacuum system
- Detectors can only be used in high vacuum
electrical breakdown in elevated pressure environments



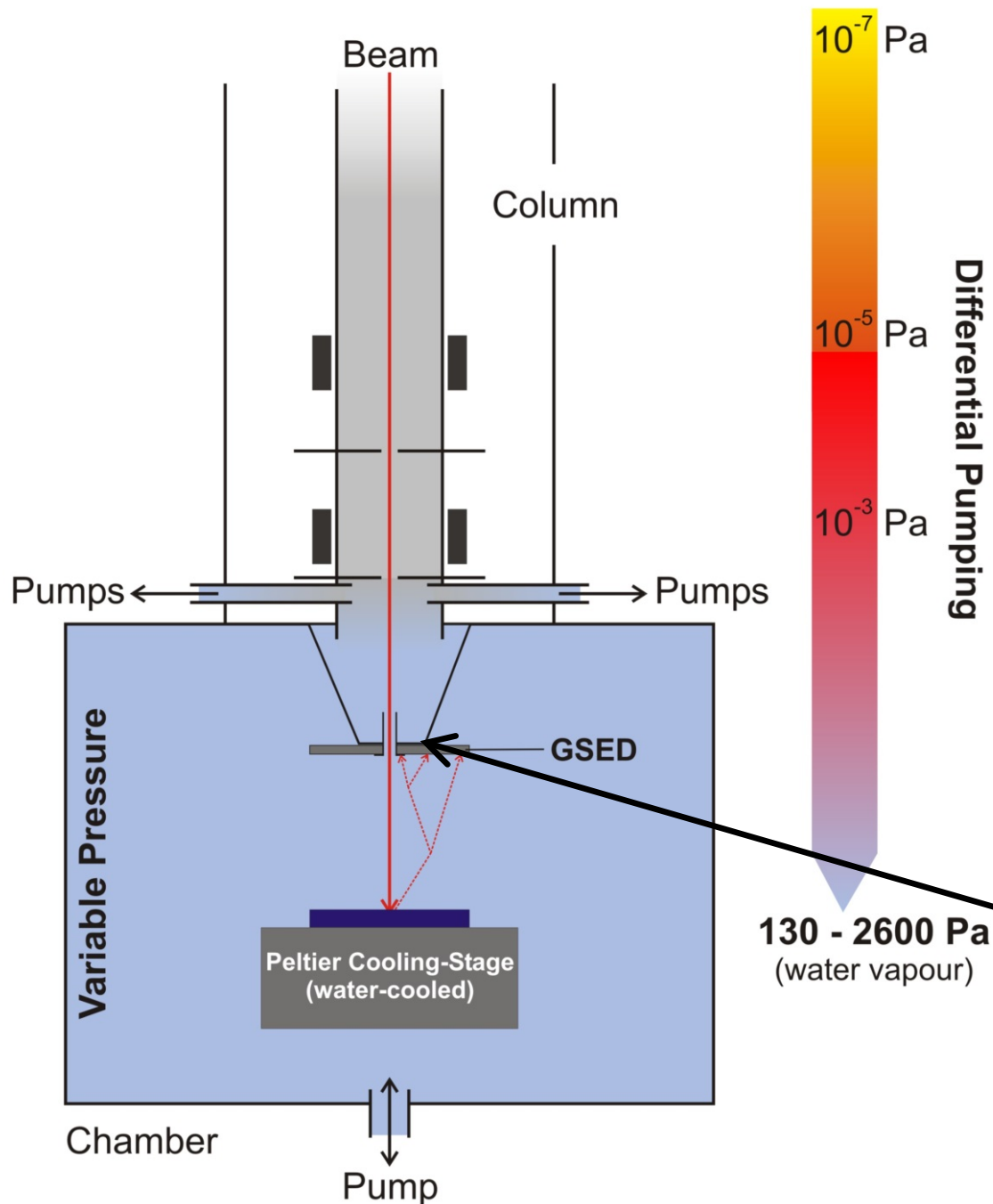
Special designed microscopes operated under variable (H_2O -)pressures

Chamber pressures between 100 and 2600 Pa



Environmental Scanning Electron Microscope (ESEM)

The Environmental Scanning Electron Microscope

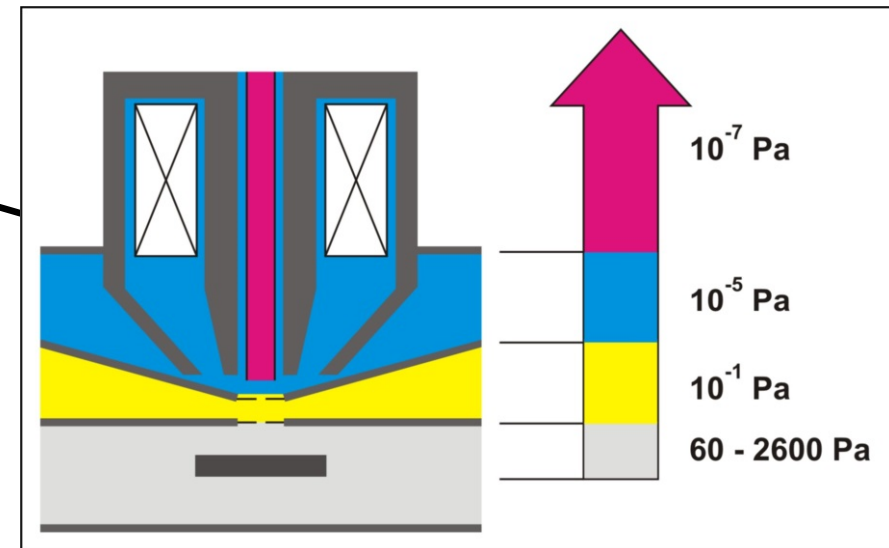


1. ESEM-Mode (low-Vac Mode)

- 50 - 200 Pa
- Imaging of beam sensitive samples

2. Wet-Mode 130 - 2600 Pa

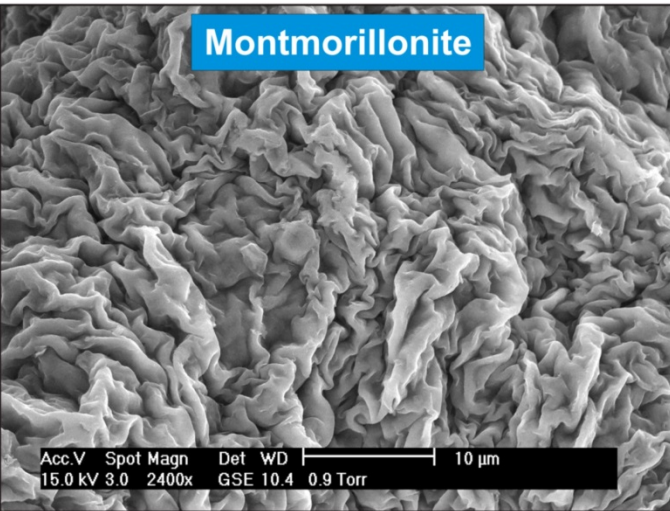
- Peltier-Stage
- GSE-Detector



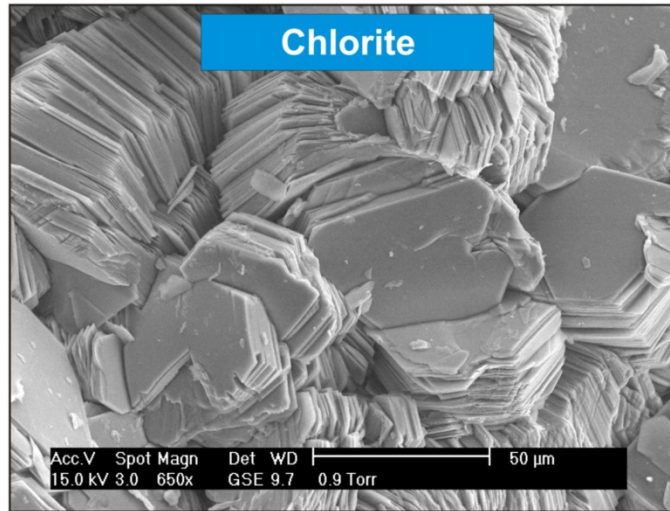
"Differential Pumping"

Imaging of Clays

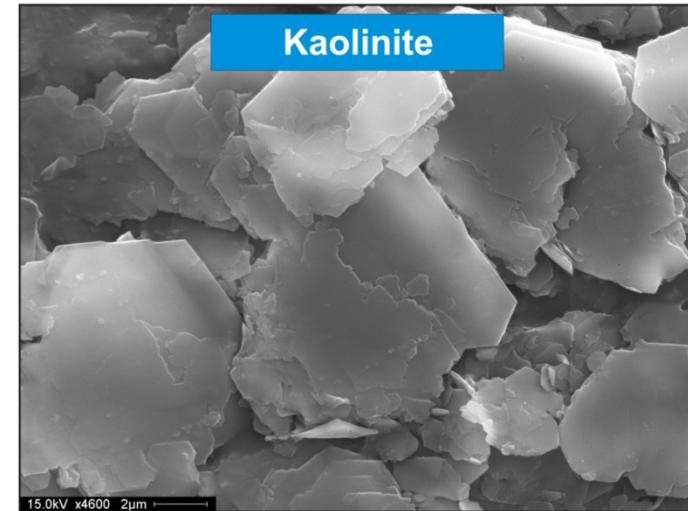
Montmorillonite



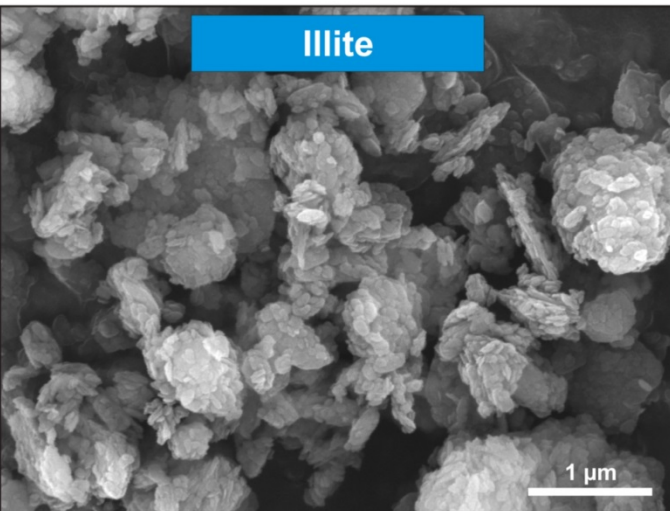
Chlorite



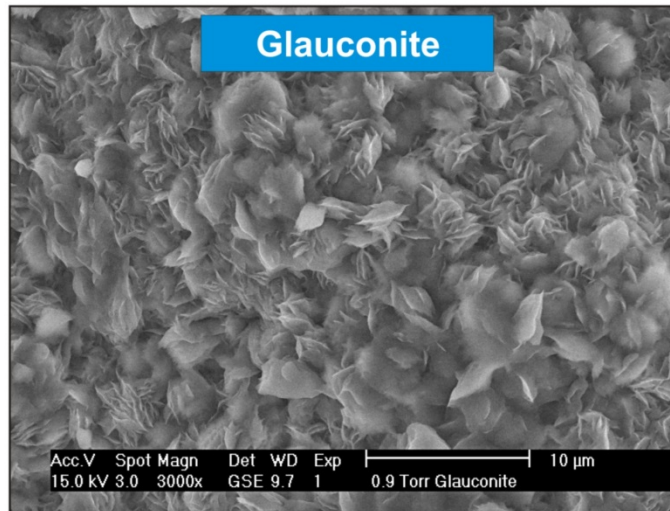
Kaolinite



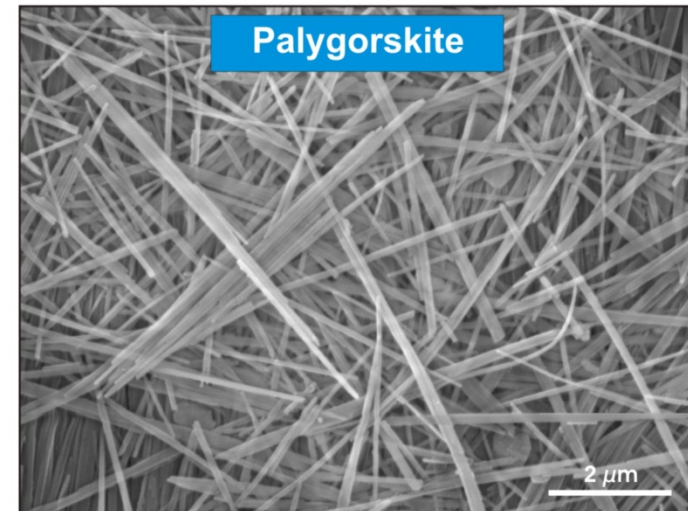
Illite



Glauconite



Palygorskite

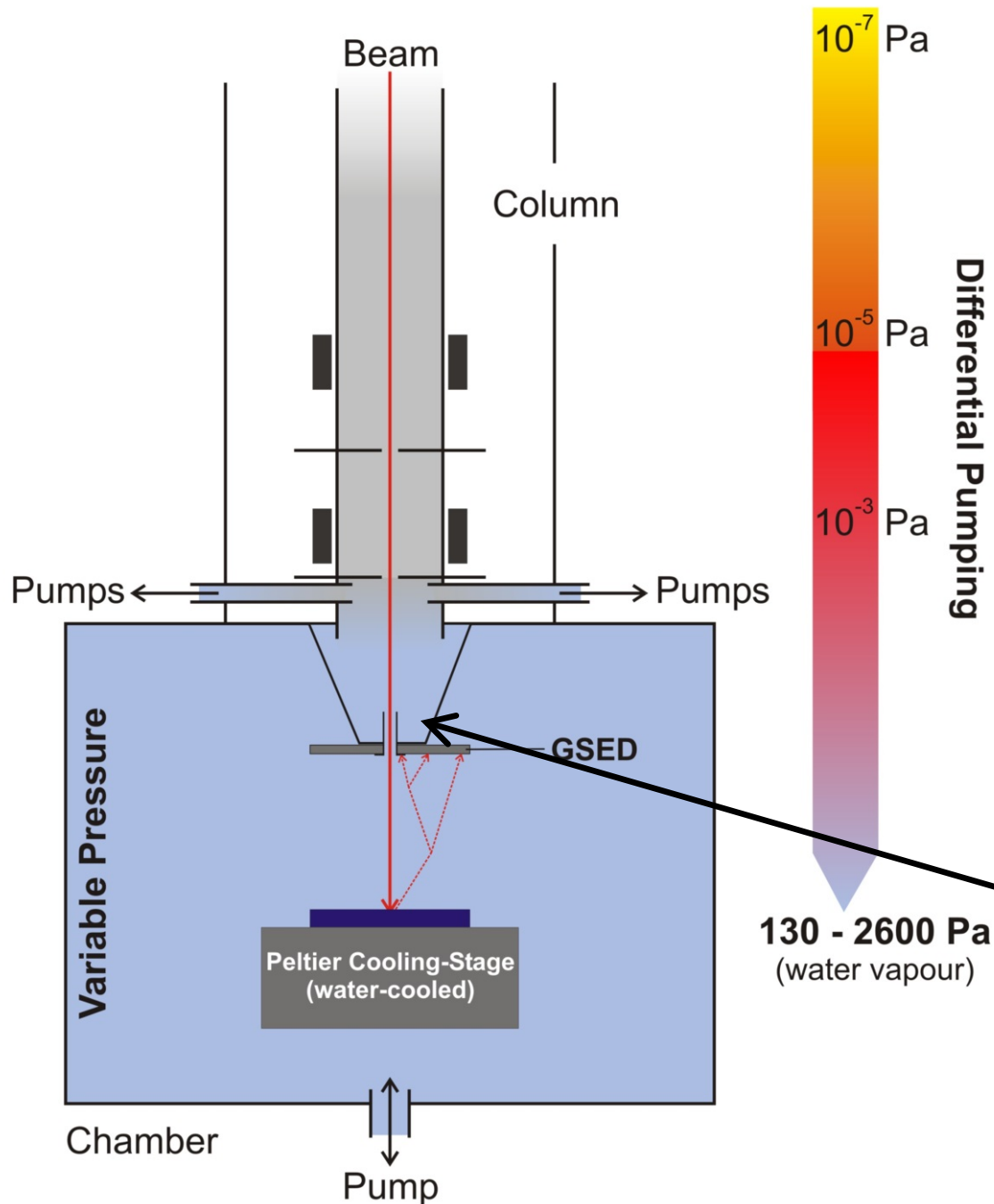


Adushkin V.V., Friedrich F. et al. (2015), *Doklady Earth Sciences*, 460, 137.

Adjdir M., Friedrich F., et al. (2009). *Applied Clay Science*, 46, 185.

Images: www.minersoc.org/pages/gallery/claypix/index.html & <http://www.fei.com/image-contest/2015/>

The Environmental Scanning Electron Microscope

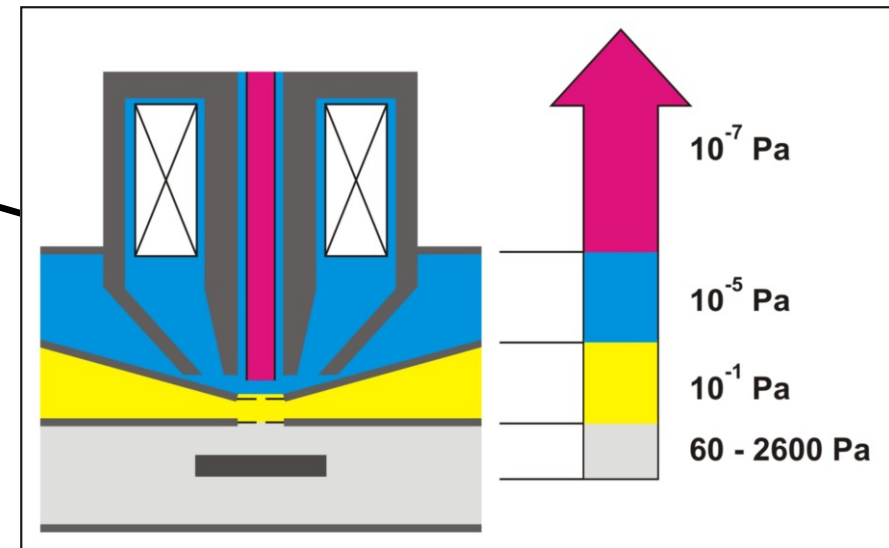


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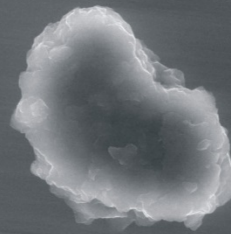
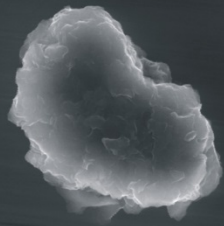
- Peltier-Stage
- GSE-Detector



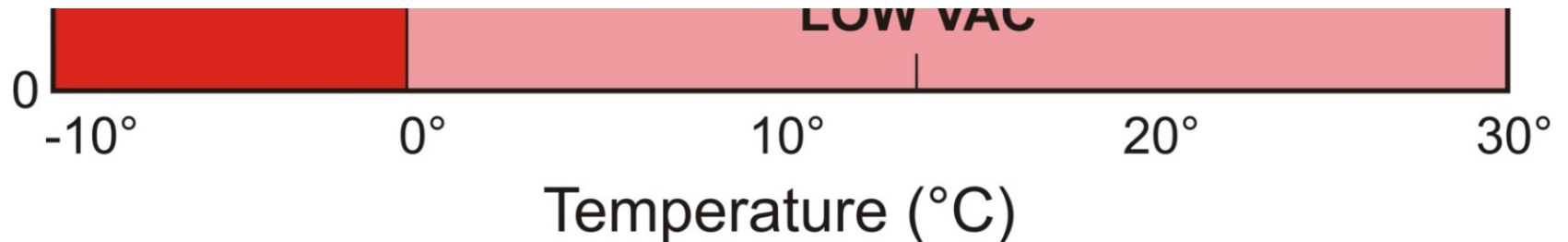
"Differential Pumping"

Phase Diagram of Water

Precise adjustment of water vapour pressure (= relative humidity) around the sample

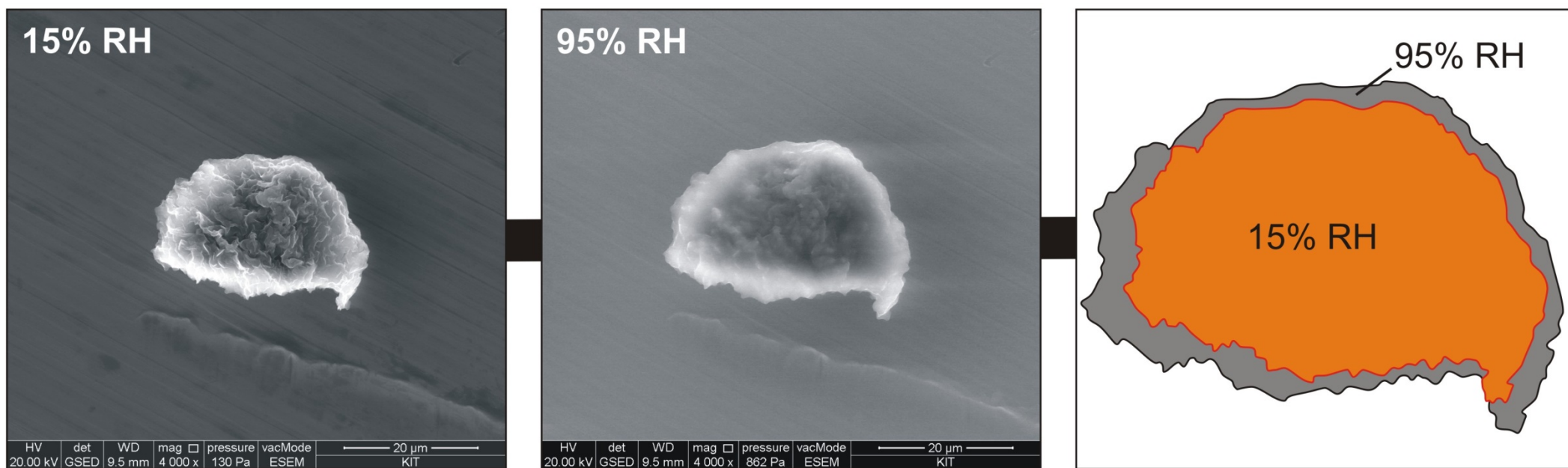


Even imaging of liquid water is possible!



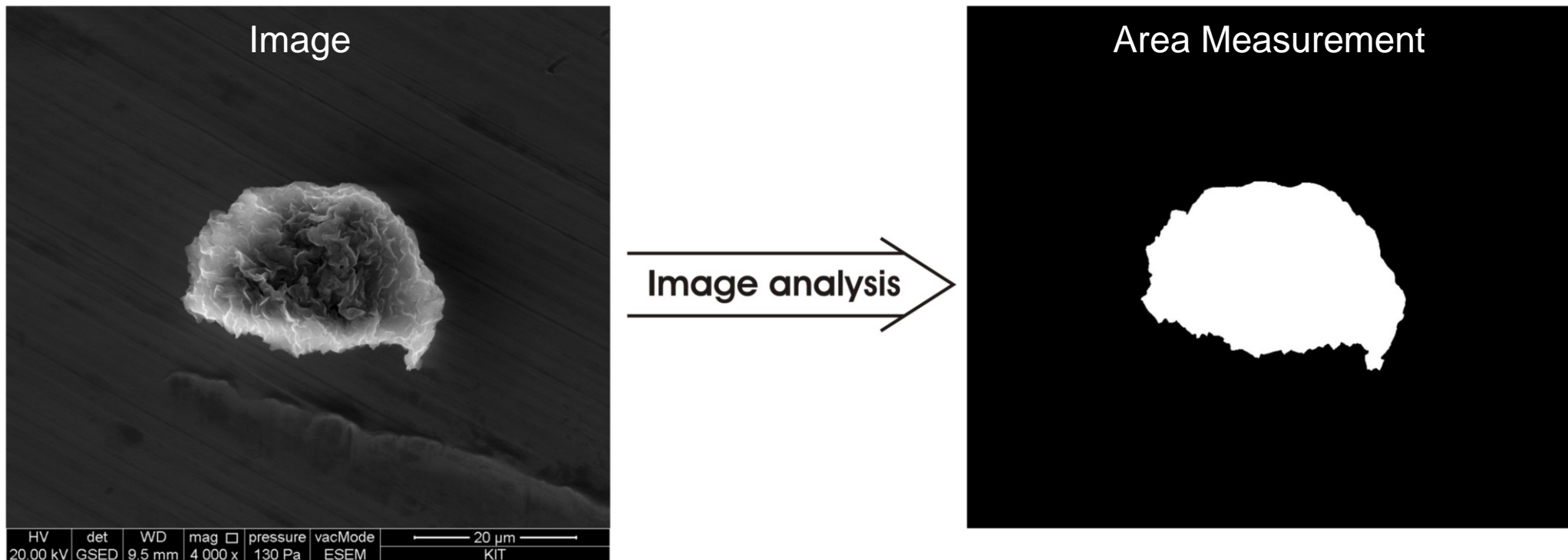
Bentonite Hydration

(Febex-)Bentonite Aggregates
(Fraction < 2 μm)



Changes in aggregate morphology and area are visible

Data evaluation with digital image analysis (open source software *ImageJ*)

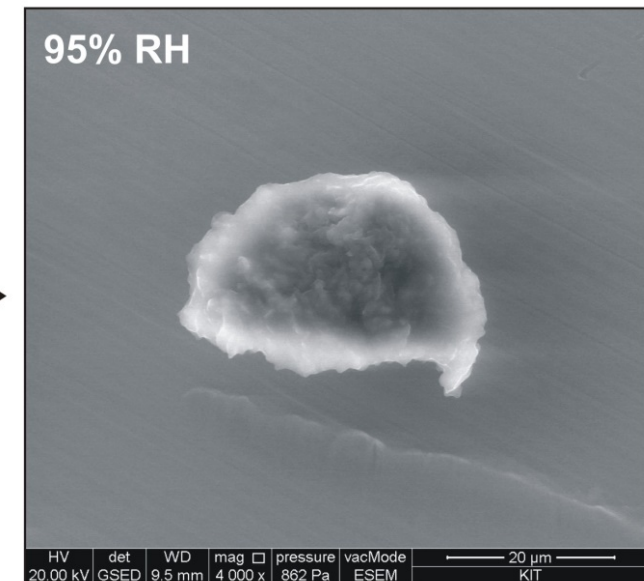
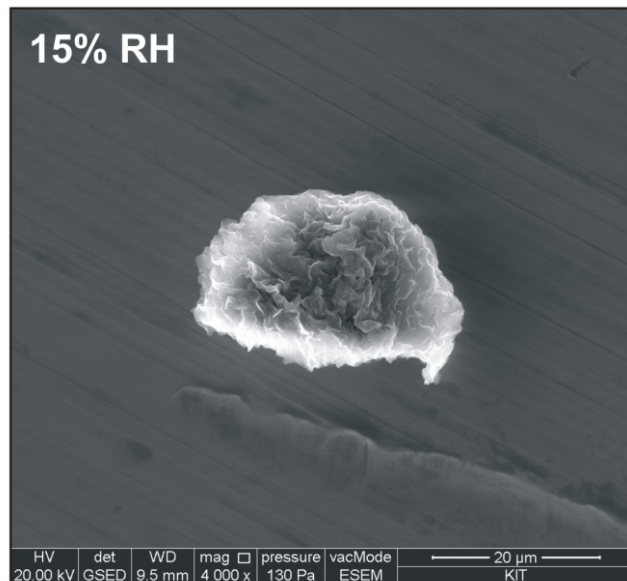


Process:

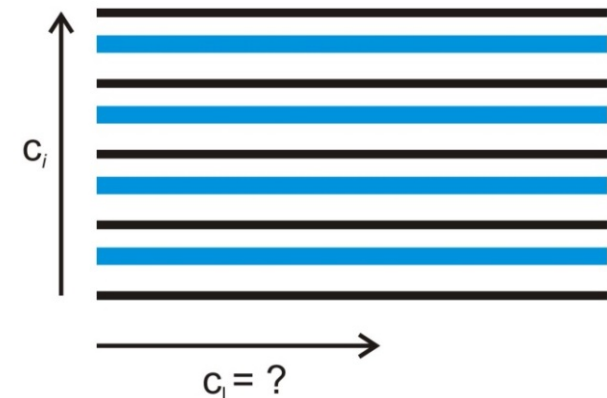
1. Defining an area of interest
 2. Selection of gray scale threshold
 3. Measurement of area
 4. Calculation of swelling rate (%) or (linear) coefficient of expansion
- $$\text{Swelling (\%)} = ((S_i - S_0) / S_0) \times 100$$

Important Questions

- Isotropic or anisotropic swelling behaviour?
- Swelling contribution perpendicular to c-axis?

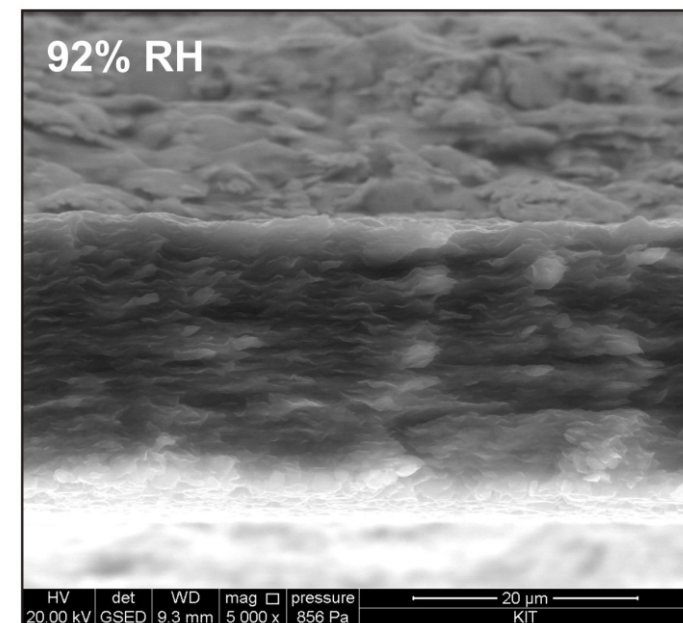
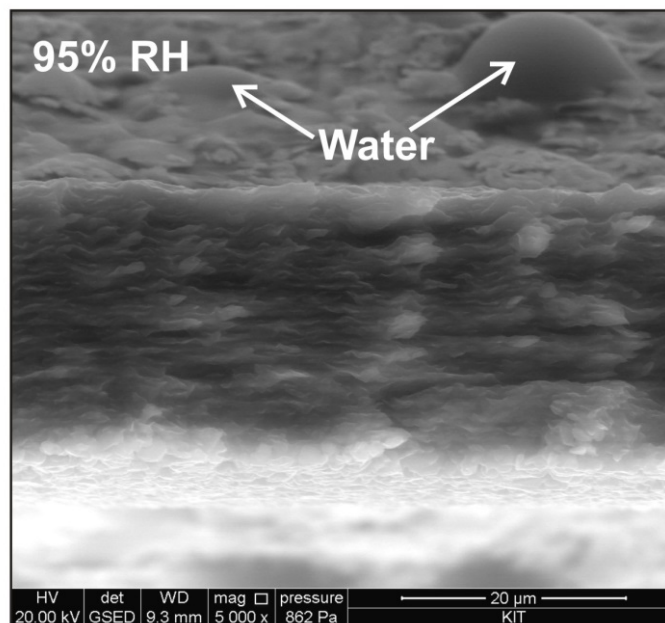
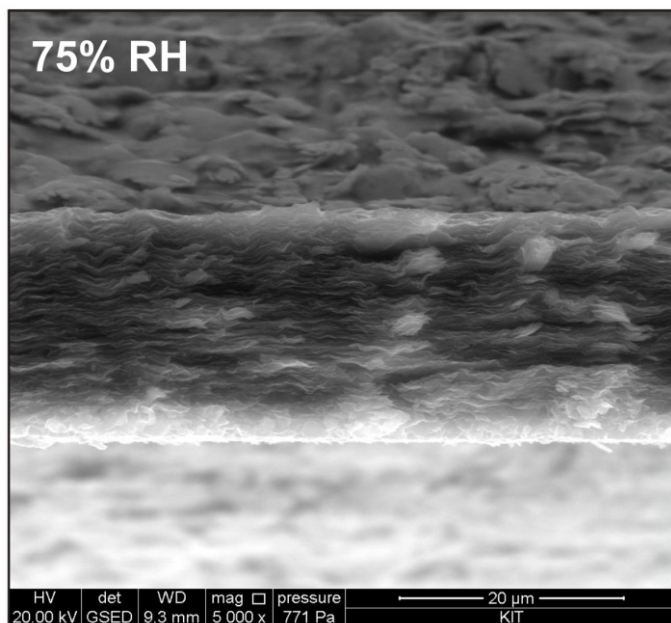
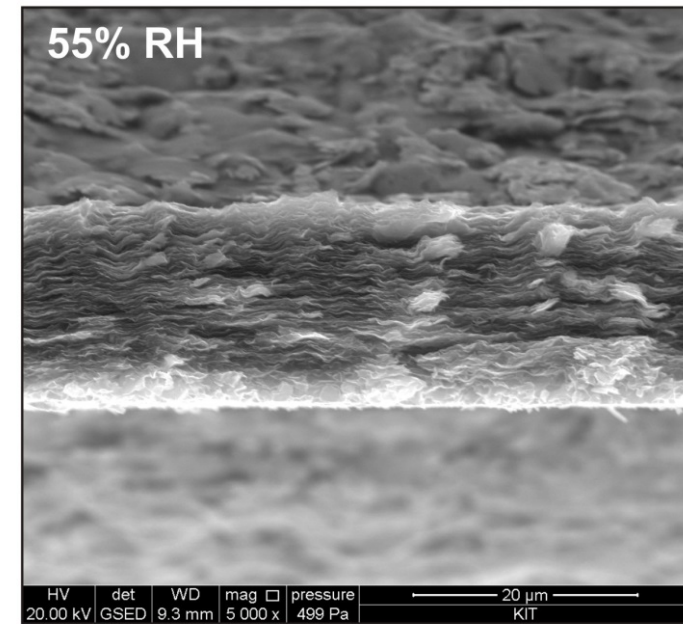
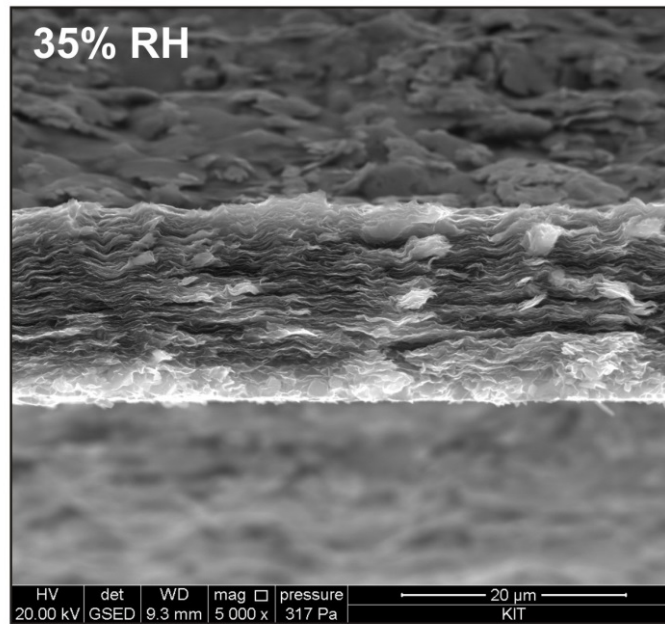
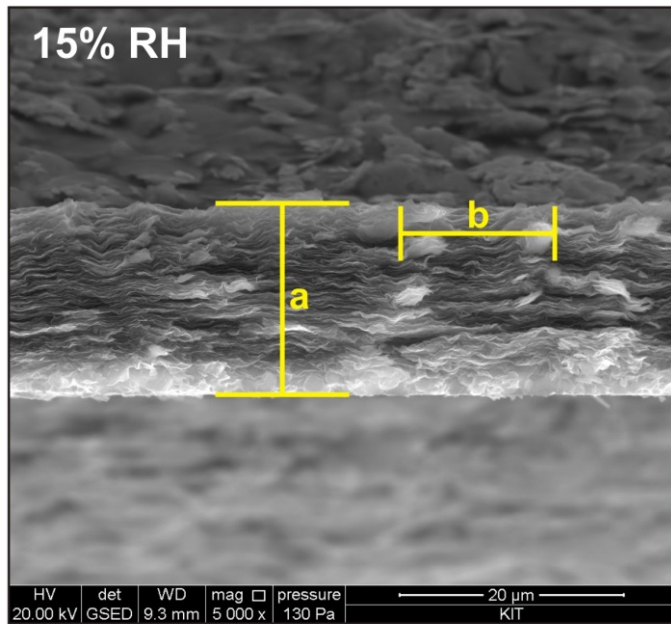


Clay particle



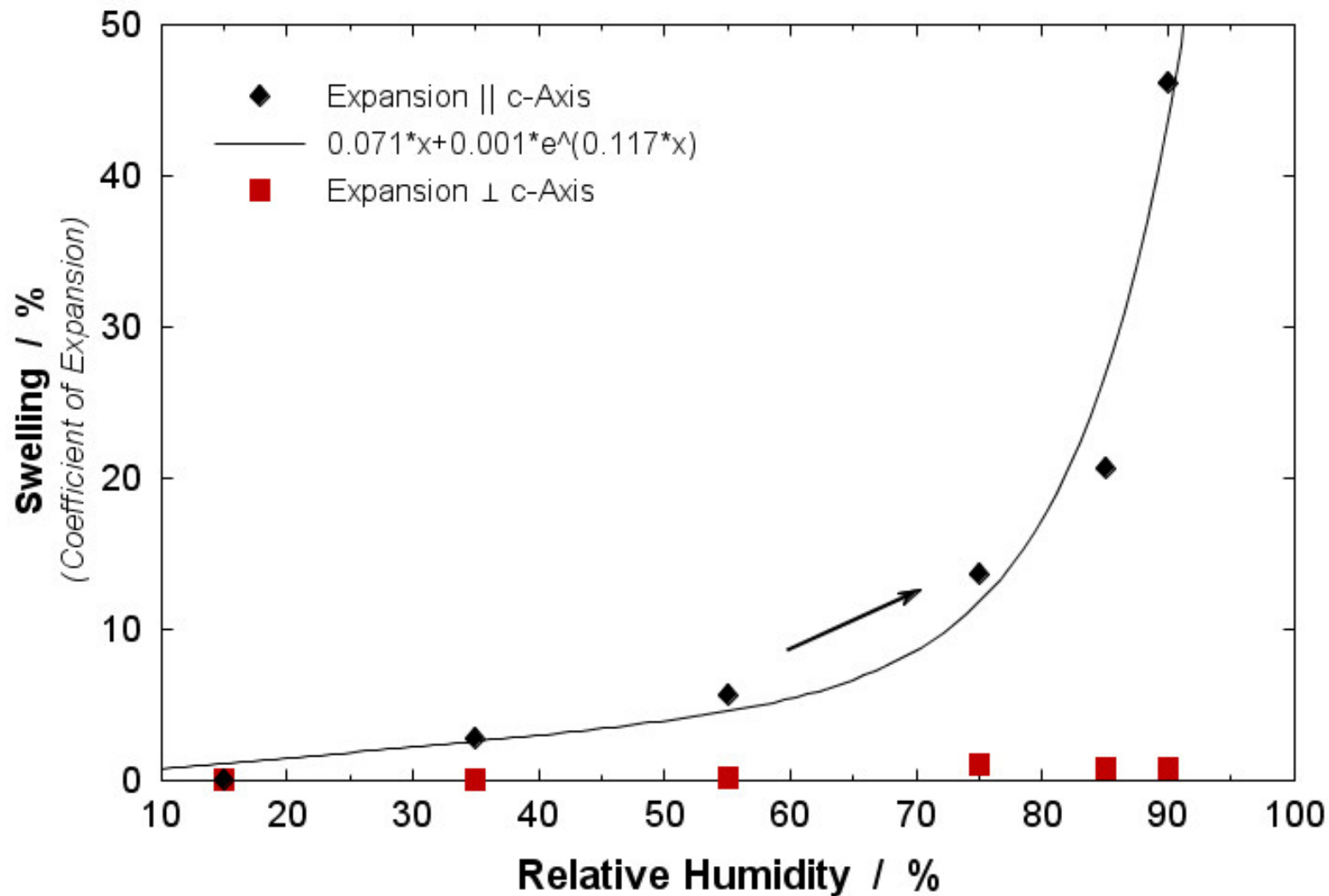
Hydrated particle

Anisotropic Swelling / Bentonite Films



- a) Expansion \parallel c-axis
b) Expansion \perp c-axis

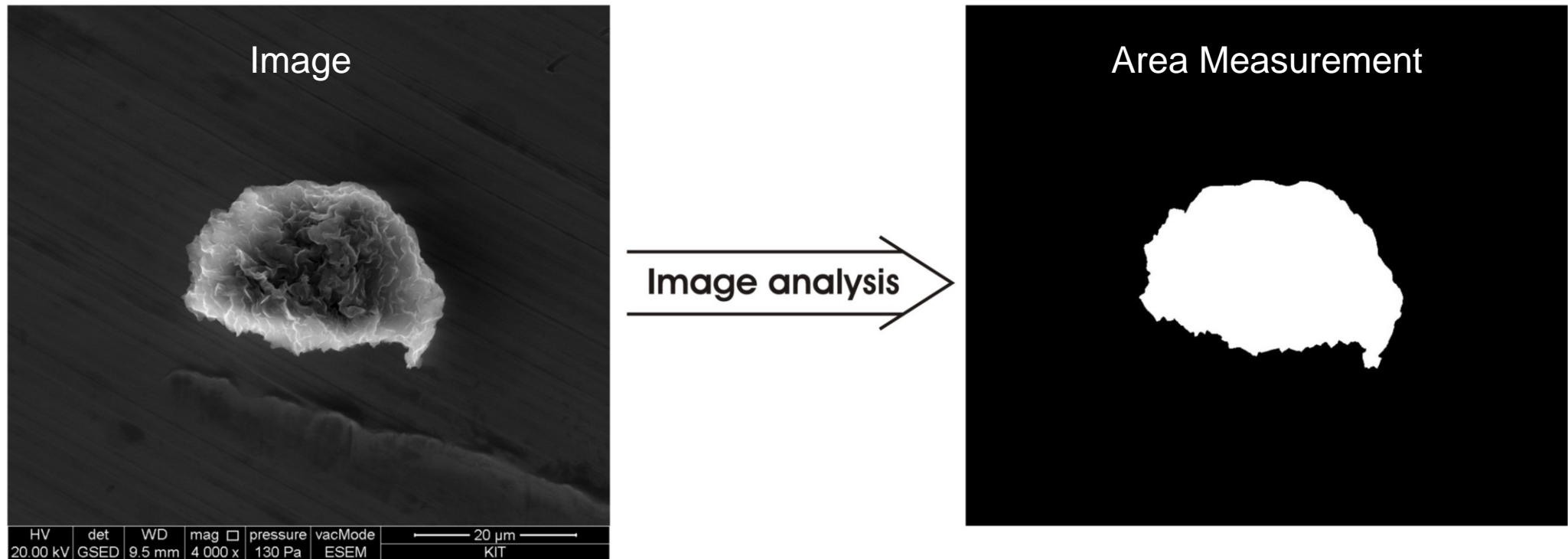
Anisotropic Swelling / Bentonite Films



Strongly anisotropic behaviour of bentonite during hydration!

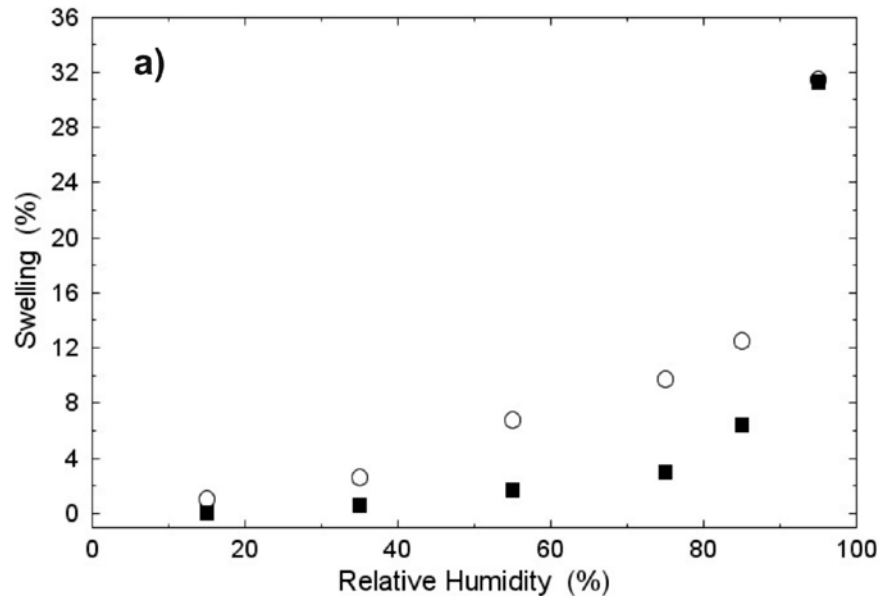
- Strong swelling along c-axis (high gradient)
- Very low swelling perpendicular to c-axis but not equal to zero. (misaligned clay particles not perfectly parallel)

Data Evaluation with digital image analysis (open source software *ImageJ*)

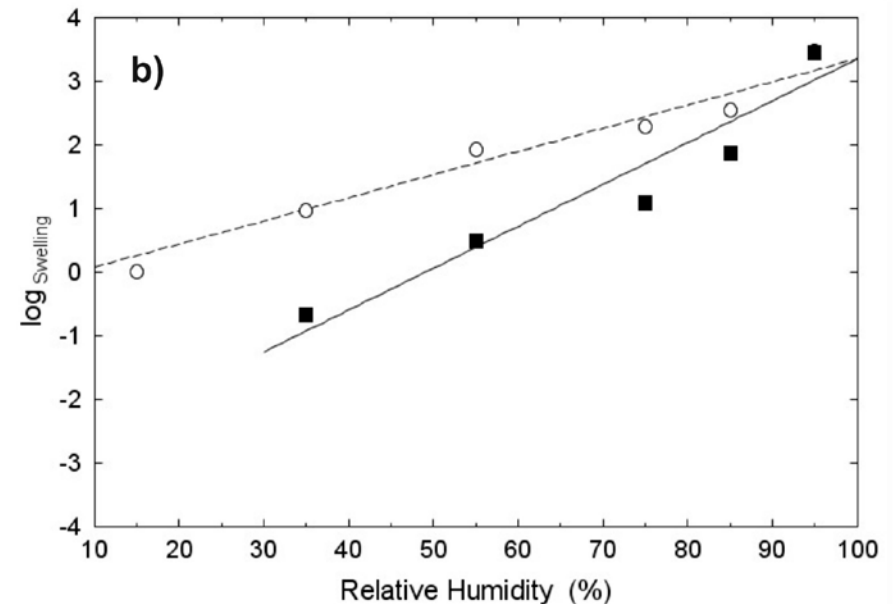


! Data evaluation procedure can be used for clay aggregates with randomly distributed particles !

Isotherm

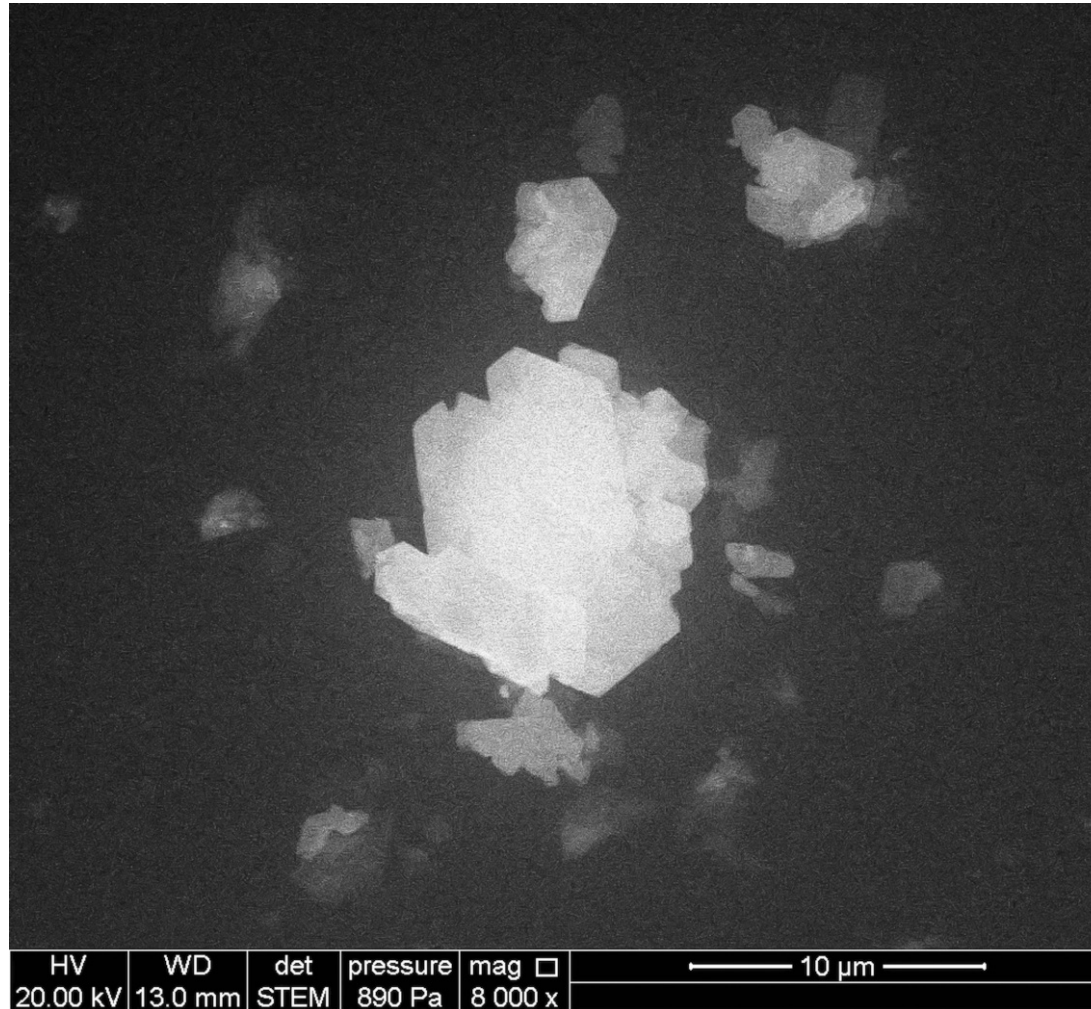


Logarithmic representation



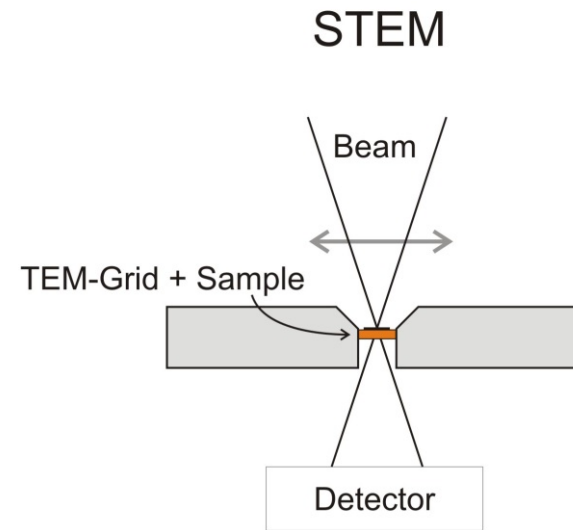
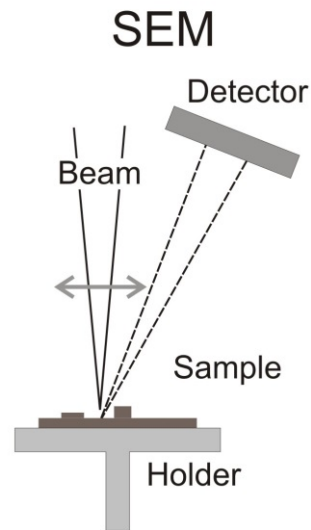
- Swelling rates are very low at the beginning.
 - Increase exponentially at high humidities.
 - Dehydration path proceeds at slightly higher swelling percentages.
 - BET-measurements show similar types of hysteresis (type H3).
 - Typical for plate-like particles giving rise to slit shaped pores.
- Fitted with a linear function.
 - Slope of hydration path is larger than dehydration path.
 - Can be assigned to first order reaction (water availability is the driving force)
 - Attributed to changes in particle arrangement and interlayer distances.

In-*situ* measurement of particles in suspension

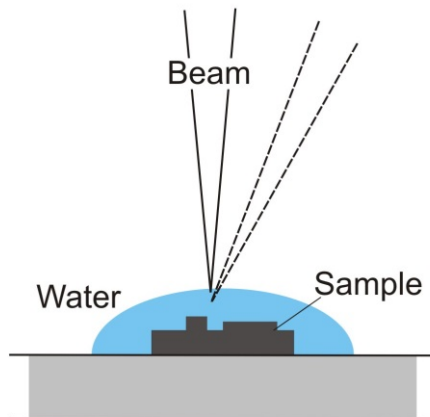


Wet-Mode ESEM vs. Wet-STEM

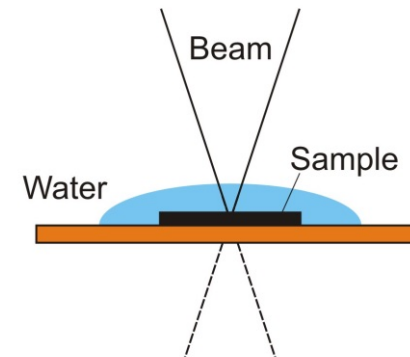
Principle



ESEM wet-Mode

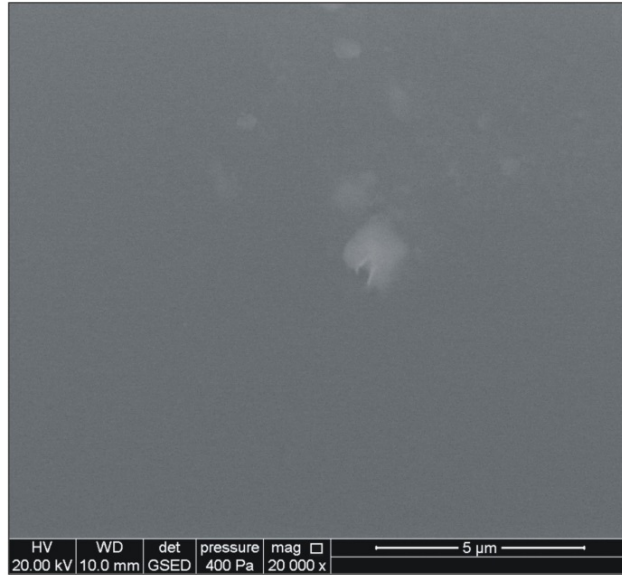


Wet-STEM

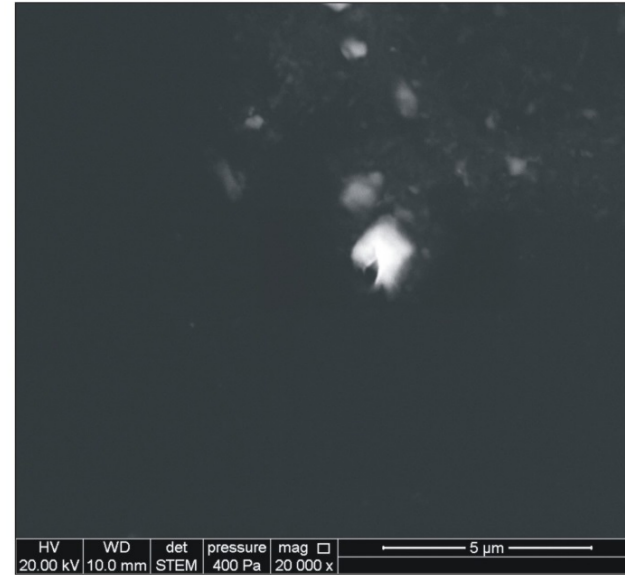


Example: Na-Febex-Suspension (< 2 mm)

ESEM wet-Mode



wet-STEM



Why wet-STEM?

Imaging of very small and thin single particles in-situ in environments from wet too dry.

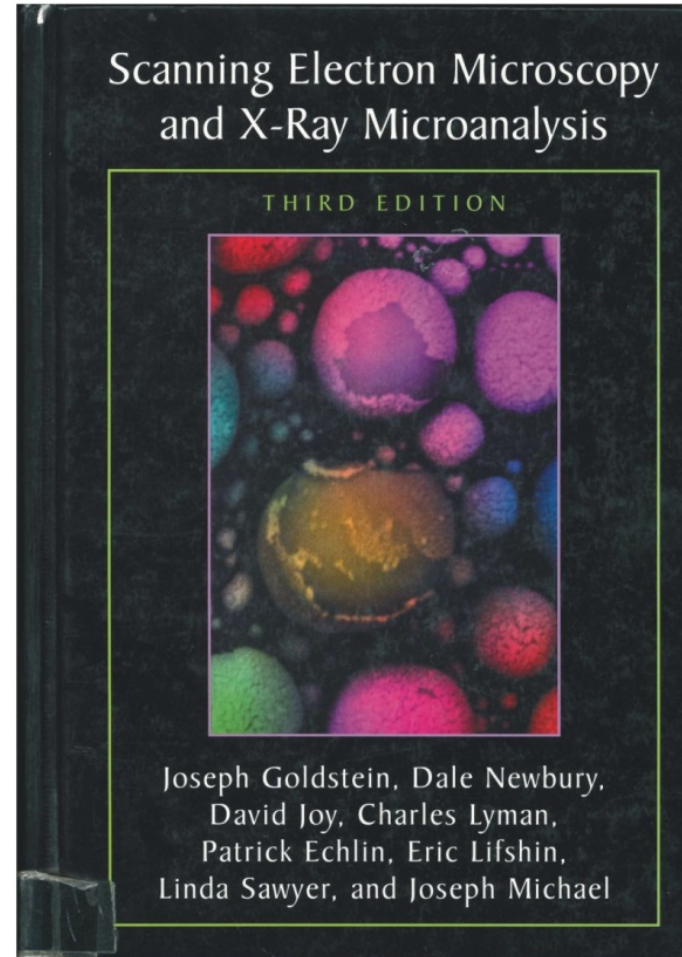
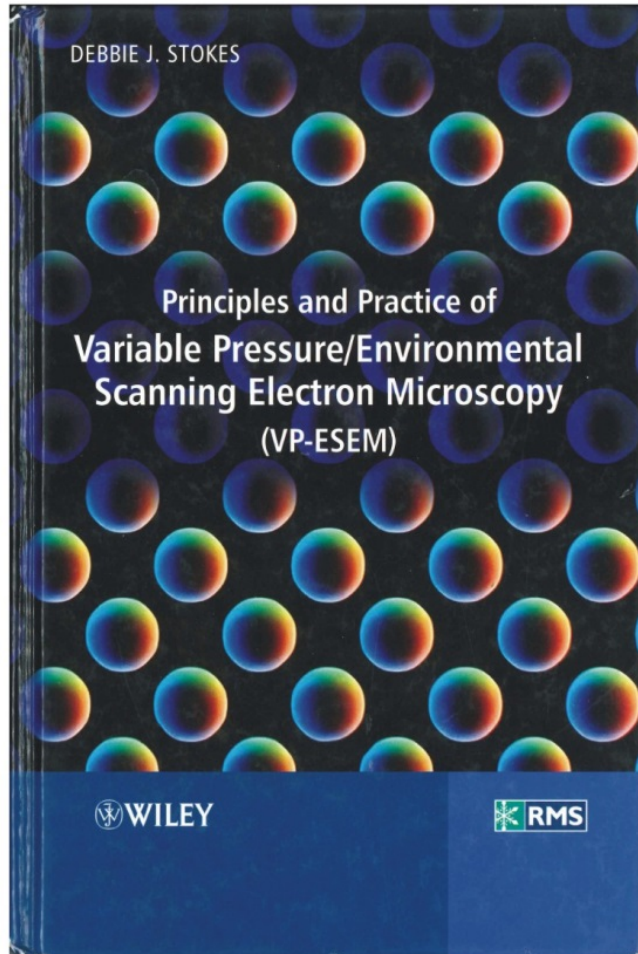
Why wet-Mode ESEM?

Imaging of particles under humid conditions (no open water).



Yellow arrows: particle sizes < 100 nm.

Further Reading



Periodicals:

e.g. *Scanning*, *Ultramicroscopy*, *Microscopy* (previously *Journal of Electron Microscopy*)

(good & free: *Microscopy & Analysis*, <http://www.microscopy-analysis.com/magazine>)